

**Search Notes**

Application/Control No.

10/826,076

Examiner

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Applicant(s)/Patent under  
Reexamination

MITTEN ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner
710	5-6,20- 29,33- 35,52- 57,308- 310	6/12/2006	CBS
370	392,389	6/12/2006	CBS
370	412,429	6/12/2006	CBS
711	118,114	6/12/2006	CBS
711	156	6/12/2006	CBS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	52,33,22	6/20/2006	CBS
	6,310	6/20/2006	CBS
370	412,429	6/20/2006	CBS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS (150 RETURNED)	6/12/2006	CBS
PALM (DOUBLE PATENTING/INVENTORS)	6/12/2006	CBS
10/818,670	6/12/2006	CBS
EAST (USPAT, USPGPUB, EPO, JPO, DERWENT, IBMTDB, USOCR)	6/12/2006	CBS
101 CHECKED	6/12/2006	CBS